Unit: mm

TOSHIBA Field Effect Transistor Silicon P-Channel MOS Type

SSM3J312T

High Speed Switching Applications Power Management Switch Applications

1.8V drive

Low on-resistance:

 $\begin{array}{l} R_{OR} = 237 m\Omega \; (max) \; (@V_{GS} = -1.8 \; V) \\ R_{OR} = 142 m\Omega \; (max) \; (@V_{GS} = -2.5 \; V) \\ R_{OR} = 91 m\Omega \; (max) \; (@V_{GS} = -4.0 \; V) \end{array}$

Absolute Maximum Ratings (Ta = 25°C)

| Characteristic | | Symbol | Rating | Unit | |
|---------------------------|-------|-------------------------|---------|------|--|
| Drain-Source voltage | | V _{DS} | -12 | V | |
| Gate-Source voltage | | V _{GSS} | ± 8 | V | |
| Drain current | DC | I _D | -2.7 | А | |
| | Pulse | I _{DP} | -5.4 | | |
| Drain power dissipation | | P _D (Note 1) | 700 | mW | |
| Channel temperature | | T _{ch} | 150 | °C | |
| Storage temperature range | | T _{stg} | -55~150 | °C | |

Note:

Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings.

Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/"Derating Concept and Methods") and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

Note 1: Mounted on FR4 board.

 $(25.4 \text{ mm} \times 25.4 \text{ mm} \times 1.6 \text{mm}, \text{Cu Pad: } 645 \text{ mm}^2)$

+0.2 2.8-0.3 1.GATE 2.SOURCE **TSM** 3.DRAIN **JEDEC** JEITA

2-3S1A

Weight: 10 mg (typ.)

TOSHIBA

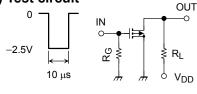
Electrical Characteristics (Ta = 25°C)

| Charac | eteristic | Symbol | Test Conditions | | Min | Тур. | Max | Unit |
|--------------------------------|---------------|----------------------|--|---------|------|------|------|------|
| Drain-Source breakdown voltage | | V (BR) DSS | $I_D = -1 \text{ mA}, V_{GS} = 0$ | | -12 | _ | _ | V |
| | | V (BR) DSX | $I_D = -1 \text{ mA}, V_{GS} = +8 \text{ V}$ | -4 | _ | | | |
| Drain cut-off curre | nt | I _{DSS} | $V_{DS} = -12 \text{ V}, V_{GS} = 0$ | | | _ | -10 | μΑ |
| Gate leakage curr | ent | I _{GSS} | $V_{GS}=\pm 8V,\ V_{DS}=0$ | | _ | _ | ±1 | μА |
| Gate threshold vol | tage | V _{th} | $V_{DS} = -3 \text{ V}, I_{D} = -1 \text{ mA}$ | | -0.3 | _ | -1.0 | V |
| Forward transfer a | dmittance | Y _{fs} | $V_{DS} = -3 \text{ V}, I_{D} = -1 \text{ A}$ | (Note2) | 2.7 | 4.5 | | S |
| Drain-Source on-resistance | | R _{DS (ON)} | $I_D = -1.0 \text{ A}, V_{GS} = -4.0 \text{ V}$ | (Note2) | | 69 | 91 | mΩ |
| | | | $I_D = -0.75 \text{ A}, V_{GS} = -2.5 \text{ V}$ | (Note2) | _ | 97 | 142 | |
| | | | $I_D = -0.3 \text{ A}, V_{GS} = -1.8 \text{ V}$ | (Note2) | | 137 | 237 | |
| Input capacitance | | C _{iss} | | | _ | 550 | _ | |
| Output capacitance | | Coss | $V_{DS}=-10\;V,V_{GS}=0,f=1\;MHz$ | | _ | 170 | _ | pF |
| Reverse transfer of | apacitance | C _{rss} | C _{rss} | | _ | 155 | _ | |
| Total Gate Charge |) | Q_g | | | _ | 7.5 | _ | |
| Gate-Source Charge | | Q_{gs} | V _{DS} = -6 V, I _{DS} = -2.7 A V _{GS} = -4 V | | | 6.0 | _ | nC |
| Gate-Drain Charge | | Q_{gd} | | | | 1.5 | | |
| Switching time | Turn-on time | t _{on} | $V_{DD} = -10 \text{ V}, I_D = -0.75 \text{ A},$ $V_{GS} = 0 \sim -2.5 \text{ V}, R_G = 4.7 \Omega$ | | | 32 | | |
| | Turn-off time | t _{off} | | | _ | 37 | _ | ns |
| Drain-Source forward voltage | | V _{DSF} | $I_D = 2.7A, V_{GS} = 0 V$ | (Note2) | _ | 0.85 | 1.2 | ٧ |

Note2: Pulse test

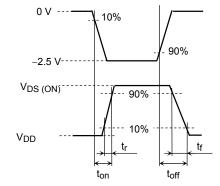
Switching Time Test Circuit

(a) Test circuit



(b) V_{IN}

(c) Vout



$$V_{DD} = -10 \text{ V}$$

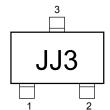
 $R_G=4.7\;\Omega$ D.U. ≦ 1%

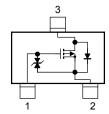
 V_{IN} : t_r , $t_f < 5$ ns Common Source

 $Ta = 25^{\circ}C$

Marking

Equivalent Circuit (top view)





Precaution

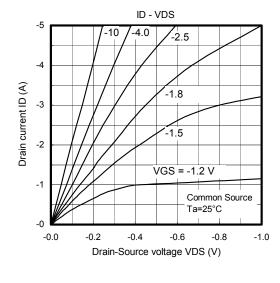
Vth can be expressed as the voltage between gate and source when the low operating current value is ID=-1mA for this product. For normal switching operation, $V_{GS\ (on)}$ requires a higher voltage than V_{th} , and $V_{GS\ (off)}$ requires a lower voltage than V_{th.}

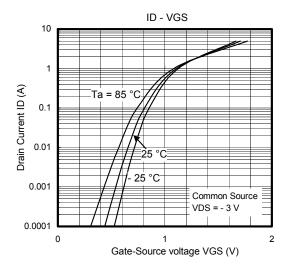
(The relationship can be established as follows: $V_{GS (off)} < V_{th} < V_{GS (on)}$)

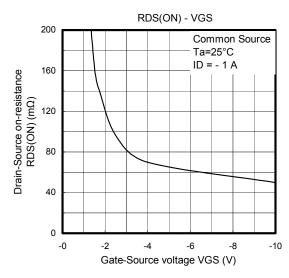
Take this into consideration when using the device.

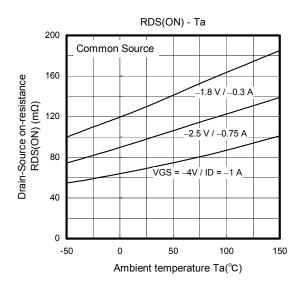
Handling Precaution

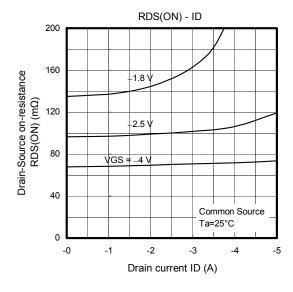
When handling individual devices which are not yet mounted on a circuit board, be sure that the environment is protected against electrostatic discharge. Operators should wear anti-static clothing, and containers and other objects that come into direct contact with devices should be made of anti-static materials.

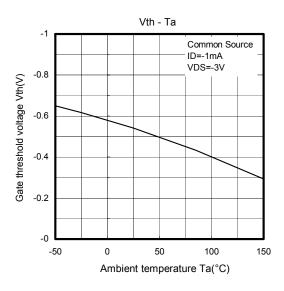


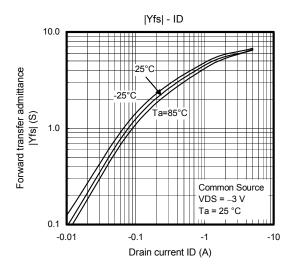


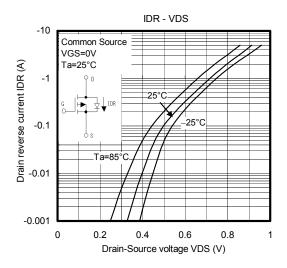


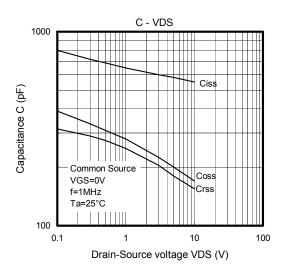


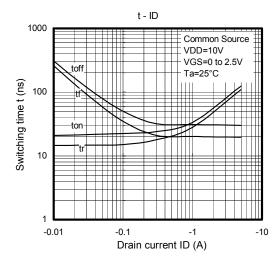


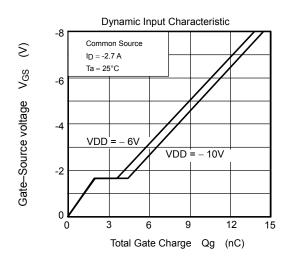


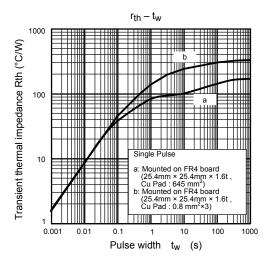


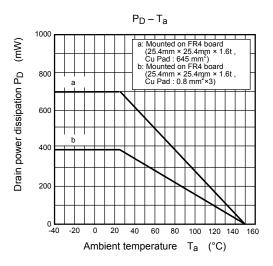












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20070701-EN GENERAL

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